Notice of References Cited

Application/Control	Reexaminati	Applicant(s)/Patent Under Reexamination VAN VALEY, EDWIN T.		
Examiner	Art Unit			
John J. Wilson	3732	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-		NONE	
	В	US-			
	C	US-			
	۵	US-			
	E	US-			
	F	US-			
	G	US-	3		
	Ξ	US-			
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р	•				
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.